

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under

Reexamination

MIYANO ET AL.

Examiner

ANISH DESAI

Art Unit

1794

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0028895 A1	02-2004	Yamakami et al.	428/354
*	B	US-4,285,029	08-1981	McCoy, Marshall W.	362/84
*	C	US-4,307,729	12-1981	Hart et al.	600/540
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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